

**Search Notes**

Application/Control No.

10/627,742

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

AOTSUKA, YASUO

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	223.1	1/24/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PG PUB, JPO, EPO, DERWENT, IBM_TDB)	1/24/2007	NT
348/222.1 (text search - see search history printout)	1/25/2007	NT
Discussed at QEM of 2622	1/24/2007	NT
Text search all classes 358 & 382 see search history printout	1/28/2007	NT
Inventorship search	1/28/2007	NT